


<b>Search Notes</b> 	<b>Application/Control No.</b> 10799139	<b>Applicant(s)/Patent Under Reexamination</b> DUFF ET AL.
	<b>Examiner</b> Flores, Leon	<b>Art Unit</b> 2611

<b>SEARCHED</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
375	316, 376	4/9/2007	LF

<b>SEARCH NOTES</b>		
<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Consulted with SPE David Payne in regards to the patentability of the claims.	4/13/2007	LF
Checked for double patenting.	4/9/2007	LF
Search in IEEE	4/9/2007	LF

<b>INTERFERENCE SEARCH</b>			
<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>